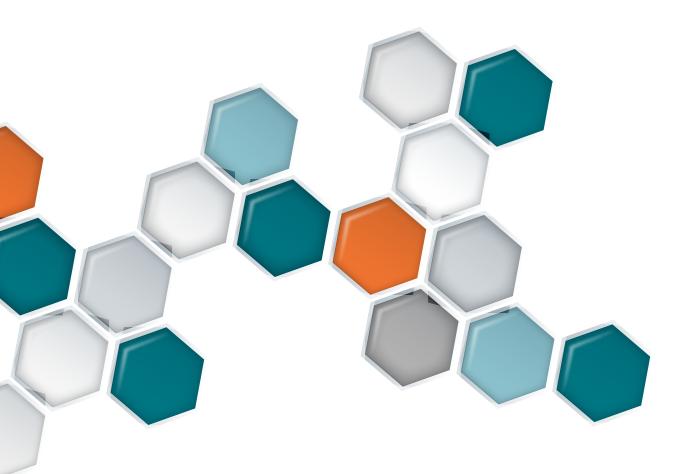




DIE SORTING PRODUCT OVERVIEW



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OVERVIEW

MACHINE SPECIFICATIONS

		DS ECC)-LINE		DS MERLI	N	DS L	ASER	ALBATI	ROSS
UPH (UP TO)		6.000		30.000/45.000/55.000		12.	000	10.0	00	
FLEXIBILITY	Flip	\checkmark		\checkmark		١	/			
	Non-Flip	\checkmark		(√)		>	<	(√)		
INPUT	Wafer					۱	/	\checkmark		
	T&R	\checkmark		(√)		>	<	Х		
	JEDEC Tray / Custom Tray			Х		۱	/			
	Hoop ring			Х		۱	/			
OUTPUT	T&R			\checkmark			۱	/	\checkmark	
	Wafer	√ (1	2")	√ (24")		>	K	\checkmark		
	Waffle Pack / Gel-Pak®	\checkmark		\checkmark		>	<			
	JEDEC Tray / Custom Tray	\checkmark		(√)		>	K	\checkmark		
	Combination of 2 outputs in 1 machine	\checkmark		Х		١	/	Х		
VISION / AOI	Front Side	\checkmark		\checkmark		١	/			
	Back Side	\checkmark		$\sqrt{+ IR*+ LG**}$		١	/			
	Sidewall	$\sqrt{+ IR^*}$		$\sqrt{+ IR^{*}}$		$\sqrt{+}$	IR*			
	Place	\checkmark		\checkmark		١	/			
	After sealing	\checkmark		$\sqrt{+IR^*}$		$\sqrt{+}$	IR*			
WAFER SIZE	(6"/8"/12")		,	\checkmark		۱	/			
DIE SIZE	Minimum	0.25 x	0.25		0.2 x 0.4		0.4 >	k 0.4	0.7 x	0.7
RANGE (in mm)		Flip	15 x 15	Sta	ndard	7 x 7			35 x	35
	Maximum	Non flip	25 x 25	Option	Flip Chip Non flip	9 x 9 12 x 12	10>	k 10	Option	45 x 45
ELECTRICAL	DIE TEST	Х			Х		>	<	Х	

*IR- Infrared inspection **LG-Laser groove inspection





MÜHLBAUER GROUP AT A GLANCE

MÜHLBAUER'S BUSINESS UNITS AND SITES

Founded in 1981 in the heart of Bavaria, the Mühlbauer Group has ever since grown to a leading global player in the fields of Parts & Systems, Semiconductor Related Products, Document Solution Related Products and TECURITY® Solutions. With around 3,500 employees, technology centers in Germany, Malaysia, Slovakia, the U.S.A. and Serbia and 35 sales and service locations worldwide, Mühlbauer created a strong competence network around the globe.

We continuously invest in the latest technologies and innovative processes to enhance our competences and provide you with optimized solutions. Our in-house precision part production MPS – Mühlbauer Parts & Systems – guarantees unlimited flexibility and highest customer satisfaction. Our business unit AUTOMATION does not only develop and assemble individually customized production systems, but also provides matching software solutions for the production process of Document and Solution Related Products. Vision inspection technologies as well as semiconductor and RFID applications complete our comprehensive portfolio.

Our business unit TECURITY[®] is established as a competent partner for the implementation of security systems for identifying and verifying both documents and individuals. Our clients benefit from more than three decades experiential value which we have gained during the realization of over 300 ID projects worldwide.







Mühlbauer Bosnia & Herzegovina

Mühlbauer China



Mühlbauer Serbia

•

Mühlbauer

Malaysia



Mühlbauer

Slovakia







MPS Precision Parts & Surface Engineering

AUTOMATION Production Equipment & Systems





WORLD OF TECURITY® Government & Technology Solutions

MANUFACTURING EXECUTION SYSTEMS



MB MCES is a personalization management software, which integrates incoming data with product definitions and controls the associated physical and electrical personalization processes. MB MCES handles personalization data from a variety of different input methods and formats.



MB INCAPE is Mühlbauer's Production Management Software for the production and personalization of electronic cards and documents (e.g. ID cards, ePassports, Driver's Licenses, EMV or GSM cards). Combining data management, production control and material management, the system allows for highly automated processes. It processes customer- and application-specific production, personalization, quality control and document delivery scenarios with highest solution flexibility.



MB PALAMAX[®], Mühlbauer's Smart Factory solution, is developed for card, tag or booklet productions, personalization factories and semiconductor backend shop floors to set and collect process data to monitor and improve the efficiency of production and personalization for later processing, visualization and statistical analysis.



MB TOOL LEADER is a software package which consists of several applications and serves as a reliable link between the individual systems involved in the production process. By means of MB TOOL LEADER, the entire process chain – from the incoming order to the final precision part – can easily be monitored and controlled. This real-time machine monitoring guarantees an automated production process. Production errors can be detected and solved at an early stage. Thus, MB TOOL LEADER reduces the machine downtimes, which in turn leads to an increase of the machine's productivity by up to 20 percent.



Configurable workflow steps regarding personalization, quality assurance & issuance



Fully-automated processing & production management



Scalability regarding different documents, machines & personalization locations



Flawless integration of Mühlbauer's material management system (MB INCAPE WAREHOUSE)



Connection to card / document management systems via web service, database, file-based interface



Standard interface to personalization machines with integration of third-party machines possible



Integration of MB USER MANAGEMENT



Full coverage of production control requirements (security industry & EMV standards)



Seamless connection to MB PALAMAX® & MB DATA PREPARATION



Simplified administration due to web-based operator clients



Monitoring of real-time performance of the production



Seamless tracking of documents from point of production to issuance



Statistical tool analyze collected data & deliver customized statistics on OEE



Tool which enables the remote operation of machines on the shop floor from a control centre



Tool which increases effectiveness & efficiency so that production becomes more profitable



Enables production engineering to prepare & test a repeatable factory set-up. Factories can switch between products within minutes.

DS VARIATION ECO-LINE

MOST FLEXIBLE AND COST-EFFICIENT HANDLING SYSTEM

to significantly lower the initial investment cost while, at the and sidewall inspection result in 100% six-side chip control. same time, guaranteeing maximum functionality in one plat- Our latest IR inspection for sidewall and backside detection form. Accordingly, the DS VARIATION ECO-LINE excels espe- helps to reach an even higher output guality. THE DS VARIAcially through its cost efficient design and highly accurate AOI TION ECO-LINE can process a whole range of niche applicavision inspection capability. With the integrated high accuracy tions such as T&R, De-Taping, Tray & Waffle packs, as well as mode for the chip placement, a value of 20μ m can be reached. reconstructed wafers up to 12".

Mühlbauer's overall goal with the DS VARIATION ECO-LINE is All standard inspection features, especially the top, backside



ADVANTAGES

- Low investment cost for maximal flexibility
- Up to 12" (300 mm) reconstructed wafer
- Fast conversion time between different products
- Flexible output configuration with 2 indexer (2-in-1)
- Advanced high speed mode run up to 7.000 UPH

BENEFITS

- Combined process capability 4-in-1 » Tape and reel
- » Waffle pack and JEDEC tray sorting » Reconstructed wafer or hoop ring
- » Wafer, tray and de-taping capability
- Including flip chip and 100% 6-side inspection » Defect detection down to 7μ m defects and 5μ m on sidewall » Infrared: Sidewall inspection
- Highest placement accuracy
- $= \pm 30 \mu$ with DOT $\pm 20 \mu m$

FEATURES & ADVANTAGES

INPUT

- Standard: Wafer
- Optional: Tape & Reel / de-taping, waffle pack, JEDEC Tray / Custom Tray, hoop ring

OUTPUT

- Tape & Reel / De-taping
- Waffle Pack / Gel-Pak[®]
- JEDEC Tray / Custom Tray
- Wafer (reconstructed wafer 12") + Hoop ring
- · Combination of 2 outputs in 1 machine

WAFER

- · Mapping: wafer mapping software incl. barcode scanner MAP-host PC for data conversion into SCES/GEM format
- Size: Up to 12"

SPECIAL FEATURE

- 8/12/16/24/optional 32 mm Carrier tape cassettes
- Input tray adapter
- Input Carrier Tape feeder » De-taping
- High resolution AOI with 4, 9,12 or 25 Megapixel camera

DIE HANDLING

- Flip chip
- Direct pick & place
- Single bond head

QUALITY REQUIREMENTS

- Placement accuracy: $\pm 20 \,\mu\text{m} / \pm 30 \,\mu\text{m}$
- Rotation: ±1.5° rotation tolerance

QUALITY INSPECTION (AOI)

- Die front-side inspection
- » Die position using pattern matching or die edge detection
- » Die surface inspection
- » Chip-out inspection
- » Bump quality Inspection (bump presence, bump size (2,5D), bump position, bump bridging, bump height / co-planarity measurement
- · Die back-side inspection
- » Die position using edge detection
- » Chip out inspection
- » Laser mark position & inspection
- » Surface inspection

UPH								
	100	00	20	00	30	00	40	00



Gel-Pak®

Reconstructed

wafer



- Sidewall inspection
- » All 6 chip sides can be inspected with full speed
- » Visible light: SIDEWALL defect detection down to $10 \mu m$ without speed loss
- » Visible light and infrared light: SIDEWALL defect detection down to 5μ m with IR capability
- Place inspection
- Tilted die inspection
- Post place inspection
- After sealing inspection

AVAILABLE OPTIONS

 IR inspection Integration possible of MB PALAMAX[®] multi bin sorting

DIE SIZES

- Minimum: 0.25 x 0.25 mm Maximum
- » Flip Standard: 15.0 x 15.0 mm Optional: 20.0 x 20.0 mm
- » Non flip Standard: 25.0 x 25.0 mm

FACILITIES

• Power: 400 V, 16 A, 50/60 Hz • Air: 6 bar, oil-/waterfree Vacuum (absolute): 0,2 bar

ENVIRONMENTAL CONDITIONS

 Room temperature: 23°C±3°C • Humidity: 50% ±10% Clean room class: ISO 7

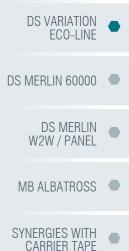
THROUGHPUT

• Flip: Up to 6,000 dies/hour • None-flip: Up to 5,000 dies/hour

MACHINE DIMENSIONS

 Height: ~2000 mm Length: ~2550 mm Depth: ~2000 mm Weight: ~2300 kg





DS MERLIN 60000



THE WORLD'S BENCHMARK IN DIE SORTING

Mühlbauer has taken the next step in high speed die sorting, The Vision inspection is updated to the latest state of the art with the DS MERLIN 60000, with a new record throughput of up to 55.000 UPH - and full 6 side inspection.

able to reach unknown speed with an additional 20% in through- Laser Groove IR inspection. put compared to the previous MERLIN 50000.

already implemented on its predecessor. It has been thoroughly as efficiently as possible. This saves a lot of time and directly tested and gained the trust of our customers with over 450 ma- increases the UPH. chines installed all over the world.

ing two rotary wheels combined with the completely automatic self-alignment system to only name two.

minimum of 4MP resolution and highest quality for visible and IR defect detection with a detection capability down to 5-10 μ m. With this newest launch to the DS MERLIN family, the system is Now also capable of using different IR wavelengths as well as

The substantial improvement in UPH is a result of the perfect The new MERLIN system comes with all the features which are alignment of the different hardware components to communicate

The DS 60000 optionally comes with our MB PALAMAX® for The machine includes the patented pick and place system us- equipment smartification and with our ARC to eliminate down time due to Carrier Tape changes. With these additions, the operator need is greatly reduced to maximize the tool efficiency.



ADVANTAGES

- 8th generation of Mühlbauer Flip Chip Tape & Reel Die Sorter
- Lower cost of ownership » no bond heads anymore
- Simple Process Tape & Reel
- » Beating the 55.000 UPH incl. vision inspection » Ready for ultra small die handling (0.2 x 0.4 mm)
- Integrated AOI 6-side inspection
- Automatic reel changer available

BENEFITS

- Including flip chip and 100% 6-side inspection
- » Defect detection of 9μ m defects and 5μ m on sidewall » Infrared: sidewall and backside IR Inspection (down to $5 \mu m$)
- Full speed and 100% sidewall inspection + IR capability
- 100% traceability with MB PALAMAX[®]

FEATURES & ADVANTAGES

INPUT Standard: Wafer Non Flip option:: Tape & Reel 6", 8", 12" (DeTaping) OUTPUT • Standard: Tape & Reel WAFER · Wafer mapping software incl. barcode scanner MAP-host PC for data conversion into SCES/GEM format Size: up to 12" SPECIAL FEATURE • Automatic self-alignment system for fully automatic product and machine setup (operator-independent) • 8, 12 or 16 mm carrier tape cassettes **DIE HANDLING** 100% Flip Chip 100% Non Flip • Two Pick & Place wheels (no turret system) in a Flip Chip configuration or one Pick & Place wheel in Non Flip configuration • Special die ejector, but standard wafer foil Automatic self-alignment QUALITY REQUIREMENTS Placement accuracy: ±30 μm • Rotation: $\pm 20 \,\mu m$ with high accuracy and $\pm 0.3^{\circ}$ tolerance QUALITY INSPECTION (AOI) Die front-side inspection (5m or 9μm defects) » Die position using pattern matching or die edge detection » Die surface inspection » Chip out inspection » Bump quality Inspection (bump presence, bump size (2,5D), bump position, bump bridging. bump height / co-planarity measurement Die backside inspection (9µm defects) » Die position using edge detection » Chip out inspection » Laser mark & position inspection » Laser groove inspection » Surface inspection

UPH	NON FLIP DS MERLIN						
	20000	25000	30000	35000			



Visible light: only surface visible

visible

inner defects

Punched Tape



 Sidewall inspection (5-10 µm defects) » All 6 chip sides can be inspected with full speed » Visible light: sidewall defect detection down to 10μ m without speed loss » Visible light and Infrared light: sidewall defect detection down to 5 μ m with IR capability Place inspection • Tilted die inspection (die height over the tape) Post place inspection After sealing inspection AVAILABLE OPTIONS • IR inspection, Die back-side at die on tool, post place, after sealing, laser groove Automatic reel changer Integration possible of MB PALAMAX[®] **REJECTS BY VISION** Defect dies are directly rejected » higher machine uptime DS VARIATION ECO-LINE DIE SIZES • Minimum: 0.2 x 0.4 mm Maximum: » Standard: 7.0 x 7.0 mm DS MERLIN 60000 » Optional: Flip: 9.0 x 9.0 mm (other sizes available) Non flip 12.0 x 12.0 mm (other die sizes upon request)

FACILITIES

 Power: 400 V. 16 A. 50/60 Hz • Air: 6 bar. oil-/waterfree • Vacuum (absolute): 0,2 bar

ENVIRONMENTAL CONDITIONS

• Room temperature: 23°C±3°C • Humidity: 50% ±10% Clean room class: ISO 7

THROUGHPUT

• Flip: up to 55,000 dies/hour Non Flip: up to 30,000 dies/hour

MACHINE DIMENSIONS

 Height: ~1990 mm Length: ~2500 mm Depth: ~1775 mm Weight: ~1800 kg

FLIP DS MERLI	N 50K	FLIP DS MERLI	N 60K 🗸
40000	45000	50000	55000

DS MERLIN

W2W / PANEL

MB ALBATROSS

SYNERGIES WITH

CARRIER TAPE

DS MERLIN WAFER-TO-WAFER / WAFER-TO-PANEL

HIGH SPEED WAFER-TO-WAFER / WAFER-TO-PANEL

new record throughput up to 30,000 UPH – already including operator-related changeovers and set-up times are no longer refull vision and sidewall inspection. On top of the significantly in- quired. New products can be introduced faster and easier than creased speed, the DS MERLIN shows 50% lower cost of owner- ever before. Due to the new construction, the inspection system ship compared to other wafer-to-wafer solutions. The completely with latest IR technology on sidewall and backside inspection new construction method of the DS MERLIN's core module fea- reaches an even higher output quality. A more intuitive software tures a special die ejector and a pick & place wheel instead of interface and an enhanced wafer handling complete this brandthe conventional bonding technology. The machine and product new die sorting system. setup have also been significantly simplified. With the complete-

With the new DS MERLIN, Mühlbauer was able to achieve a ly automatic self-alignment system, a complex and long-lasting



ADVANTAGES

- High speed Wafer-to-Wafer machine (up to 25.000 to over 40.000 UPH)
- 12" wafer reconstruction or panel size up to 24" x24" (600x 600 mm)
- Flip or Non-flip capability
- 100% Vision Inspection
- Simple process Wafer-to-Wafer / Wafer-to-Panel / JEDEC tray » Ready for ultra small die handling 0.2 x 0.4 mm
- · Best compromise between speed and accuracy improvement

BENEFITS

- Including flip chip and 100% 6-side inspection » Defect detection of 9μ m defects and 5μ m on sidewall
- » Infrared: sidewall and backside IR inspection (down to 5 μ m) • High placement accuracy $\pm 20 \,\mu\text{m} - \pm 15 \,\mu\text{m}$ (optional)
- 100% traceability with MB PALAMAX[®]

FEATURES & ADVANTAGES

INPUT
 Standard: Wafer (up to 12")
 OUTPUT Standard: panel size (150 x 300 mm) Optional: wafer size (up to 24"), panel size (up to 24" x 24") JEDEC tray / waffle pack
 WAFER Wafer mapping software incl. barcode scanner MAP-host PC for data conversion into SCES/GEM format Size: up to 12"
 SPECIAL FEATURE Automatic self-alignment system for fully automatic product and machine setup (operator independent)
DIE HANDLING Option A: 100% flip chip Option B: 100% non-flip chip
 QUALITY REQUIREMENTS Placement accuracy: ±20 μm ±15μm with high accuracy mode Rotation: ±1° rotation tolerance
 OUALITY INSPECTION (AOI) Die front-side inspection (9μm defects) Die position using pattern matching or die edge detection Die surface inspection Chip out inspection Bump quality Inspection (bump presence, bump size (2,5D), bump position, bump bridging, bump height / co-planarity measurement Die backside inspection (9μm defects) Die position using edge detection Chip out inspection Chip out inspection Suface inspection Surface inspection (5-10 μm defects) All 6 chip sides can be inspected with full speed Visible light: sidewall defect detection down to 5μm with IR capability Place inspection
 Die front-side inspection (9μm defects) » Die position using pattern matching or die edge detection » Die surface inspection » Chip out inspection » Bump quality Inspection (bump presence, bump size (2,5D), bump position, bump bridging, bump height / co-planarity measurement Die backside inspection (9μm defects) » Die position using edge detection » Chip out inspection » Laser mark position » Laser mark inspection » Surface inspection (5-10 μm defects) » All 6 chip sides can be inspected with full speed » Visible light: sidewall defect detection down to 5μm with IR capability

UPH				
	10000	20000	30000	40000





AVAILABLE OPTIONS

VAILABLE OPTIONS					
 Global alignment NEW: Laser groove IR Integration possible of MB PALAMAX[®] Output map generation Output trace file (with accuracy per / chip) Panel handling at SMEMA Standard 					
REJECTS BY VISION Defect dies with front or backside defects are rejected directly and not placed into output medium » higher machine uptime					
DIE SIZES Minimum: 0.2 x 0.4 mm Maximum: » Standard: 7.0 x 7.0 mm » Optional: Up 9.0 x 9.0 mm (other sizes available)					
ACILITIES Power: 400 V, 16 A, 50/60 Hz Air: 6 bar, oil-/waterfree Vacuum (absolute): 0,2 bar	DS VARIATION ECO-LINE	•			
Image: NVIRONMENTAL CONDITIONS DS MERLIN 60000 Room temperature: 23°C±3°C Humidity: 50% ±10% Clean room class: ISO 7					

THROUGHPUT

n

•

• Flip: up to 30.000 dies/hour with flip and sidewall (depending on configuration) • Non Flip: up to 30.000 dies/hour with sidewall (depending on configuration)

MACHINE DIMENSIONS

 Height: ~1990 mm Length: ~2500 mm • Depth: ~1775 mm • Weight: ~1800 kg

DS MERLIN W2W / PANEL

MB ALBATROSS

SYNERGIES WITH CARRIER TAPE

50000



BIG DIE AND MULTI BIN SORTER

The new DS ALBATROSS is the flagship of big die and multi bin of semiconductor Software Automation. The special die sorting sorting in one system. It is equipped with latest Industry 4.0 system includes full AOI (Automatic Optical Inspection) capabilstandards including robotic systems for material handling, auto- ity, sidewalls inspection and surface inspections to guarantee matic tool changer, cleaning stations, multifold input and output 100% high-quality output. load ports and is GEM300 compliant, which is the highest level



ADVANTAGES

- Handling of small die such as 0.7 mm all the way up to 45 x 45mm can be placed from and into different media:
- » Wafer or Tray to 2* Tray Output
- » Wafer or Tray to 6* Tape and Reel
- Flip or non-flip Capability
- 30 μ m placement accuracy
- Automatic Tool changer

BENEFITS

- Including flip chip and 100% 6-side inspection » Defect detection of $30\mu m$
- Gem300 compliant
- · Loadport compliant + OHT/AGV » Smart factory compliant

FEATURES & ADVANTAGES

INPUT • Wafer (up to 12") / Hoop Ring • JEDEC Tray	
OUTPUT • 6 x Tape & Reel • 2 x JEDEC Tray • 12 x Waffle Pack	F
 WAFER Wafer mapping software incl. barcode scanner MAP-host PC for data conversion into SCES/GEM format Size: up to 12" 	E
 ALTERNATIVE CONTACTLESS DIE RELEASE TECHNOLOGY No die ejector needles Thermal release wafer foil thin Applicable for standard & THIN dies below 30μm FOUP handling included (robotic transport to the wafer expander) No frame required 	T
DIE HANDLING • 100% flip or non-flip process • Dual bonding head	N
QUALITY REQUIREMENTS • Placement accuracy: ±30 μm	A
QUALITY INSPECTION Die frontside inspection (30 μm defects) » Die position using pattern matching or die edge detection » Die surface inspection » Chip out inspection » Bump quality Inspection (bump presence, bump size (2,5D), bump position, bump bridging, bump beight / co-planarity measurement 	

- position, bump bridging, bump height / co-planarity measurement
- Die backside inspection (30 μ m defects)
- » Die position using edge detection
- » Chip out inspection
- » Laser mark position & inspection » Surface inspection
- Sidewall inspection (30 µm defects)
- » 6 chip sides can be inspected with full speed » G 2: sidewall defect detection down to 30 μ m
- Place inspection
- Tilted die inspection (die height over the tape)
- Post-place inspection

UPH				
	2000	4000	6000	8000









After sealing inspection

DIE SIZES

• Minimum: 0.7 x 0.7 mm Maximum: » Standard: 35 x 35 mm » Big die size range: 45 x 45 mm

FACILITIES

• Power: 400 V, 16 A, 50/60 Hz • Air: 6 bar, oil- / water free Vacuum (absolute): 0,2 bar

ENVIRONMENTAL CONDITIONS

 Room temperature: 23°C ± 3°C • Humidity: 50% ± 10% Clean room class: ISO 7

THROUGHPUT

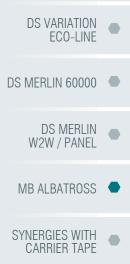
Flip: Up to 10,000 dies/hour

MACHINE DIMENSIONS

Length: ~4340 mm Width: ~4990 mm Height: ~2550 mm Weight: ~6740 kg

AVAILABLE OPTIONS

 Integration possible of MB PALAMAX[®] Automatic tool changer Load port compliant + OHT/AGV



10000 12000

SYNERGIES WITH CARRIER TAPE

ONLY MÜHLBAUER OFFERS A PERFECTLY MATCHING SOLUTION FOR CARRIER TAPE & DIE SORTING

IN THE AREA OF DIE SORTING, MÜHLBAUER IS THE ONLY COMPANY WORLDWIDE

- which can supply you with Carrier Tape machines as well as Carrier Tapes
- offering CTML as an inline machine with Die sorting system or Carrier Tape system as well as standalone machine
- Barcode in Carrier tapes available for smart and unique data handling

TRUST IN THE MOST EXPERIENCED SUPPLIER IN TERMS OF PRECISION, SPEED AND QUALITY!





MÜHLBAUER NOW LASERS BARCODES ON CARRIER TAPE. WE INVENTED A LASER STATION TO MARK **CARRIER TAPE ON DS MACHINES!**



YOUR ONE-STOP-SHOP TECHNOLOGY PARTNER

AUTOMATION

CARDS & ePASSPORTS

- IC Module Production
- Card Body & Smart Card Production
- Holderpage & Booklet Production
- Card & ePassport Personalization
- Packaging & Mailing

RFID / SMART LABEL

- Antenna Production & Inlay Assembly
- Converting
- Personalization

SEMICONDUCTOR BACKEND

- IC Module Production
- Carrier Tape Production
- Die Sorting

INDUSTRIAL INSPECTION SYSTEMS

- Packaging
- Metal Working
- Special Solutions

FUTURE TECHNOLOGIES

- Concentrator Solar Technology
- Flexible Solar Cell Technology
- Solar Panel Technology
- E-SIM PERSO
- LED Technology

TECURITY®

- ID Card Solution ePassport Solution

- Production Facilities

PARTS & SYSTEMS

- Precision Parts
- Surface Engineering

CONSULTING

- Planning & Design
- Implementation
- Ongoing Operations

SERVICE

- Updates & Upgrades

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• MB IDVERSO[®] Border Management Solution • Driver's License & Vehicle Registration Solution

Identification of Customer Requirements

· Worldwide Locations for Service & Support Worldwide Spare Parts Supply Reaction Time & Full Service Contracts • Service & Maintenance Management • Teleservice, Remote Access & Hotline (24 hours) Training & Support on Different Levels Production & Administration Support



MB PALAMAX[®], Mühlbauer's Smart Factory solution for semiconductor backend shop floors. Consisting of a NOSQL database, it is designed to set and collect process data to monitor and improve the efficiency of production. The collected process data is stored in big data sets for later processing, visualization and statistical analysis.



KEY FEATURES

- Monitor your production in real time & generate real production statistics with your preferred KPIs (for specific chip types only)
- Improve your transparency
- Gain better data to investigate, understand & portray process flows & relationships
- Run your production with improved security & optimally employed staff
- Intuitive & easy-to-use web interface
- Responsive user interface design allows optimal presentation on any chosen device
- Data collection from the shop floor of Mühlbauer equipment & also third-party equipment
- State-of-the-art big data software architecture ensures future reliability

FEATURES & ADVANTAGES



PALAMAX.MONITOR

Monitors the real-time performance of the production



PALAMAX.STATS

Statistical tool which analyzes collected data and delivers customized statistics on OEE



PALAMAX.REMOTE

Enables the remote operation of machines on the shop floor from a control centre



PALAMAX.TRACE

Allows for the auditing of single manufacturing runs



PALAMAX.MAINTAIN

Enables the implementation of maintenance on demand



PALAMAX.COST

Increases effectiveness and efficiency so that production becomes more profitable



PALAMAX.RECIPE

Enables production engineering to prepare and test a repeatable factory set-up. Factories can switch between products within minutes.



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